



00862.001336

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OFFICE OF PETITIONS PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	
	:	Examiner: A. Jankus
HIDEO TAKIGUCHI ET AL.)	
	:	Group Art Unit: 2671
Application No.: 08/573,519)	
	:	
Filed: December 15, 1995)	
	:	
For: INTUITIVE HIERARCHICAL)	
DATA DISPLAY METHOD	:	
AND SYSTEM)	February 17, 2004

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

A Request for Continued Examination is submitted concurrently herewith.

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

For the concise explanation of the relevance of the non-English documents, the Examiner is referred to the English abstract attached to those documents.

The Japanese document listed on Form PTO 1449 was cited during prosecution of a Japanese patent application corresponding to the subject U.S. application.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

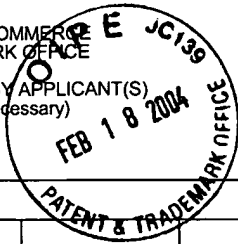
Respectfully submitted,


Attorney for Applicants

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NYMAIN407917

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. 00862.001336		APPLICATION NO. 08/573,519	
				APPLICANT HIDEO TAKIGUCHI ET AL.			
				FILING DATE December 15, 1995		GROUP 2671	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
				RECEIVED			
				FEB 23 2004			
				OFFICE OF PETITIONS			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	JP	6-180661 A	06/28/94	Japan	G06F	12/00	Abstract
	FR	2 680896	03/05/93	France	G06F	15/30	Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.